## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of Robert J. Falster et al. Serial No. To Be Assigned Filed February 11, 2002 For THERMALLY ANNEALED, LOW DEFECT DENSITY SINGLE CRYSTAL SILICON

February 11, 2002

### PRELIMINARY AMENDMENT A

TO THE ASSISTANT COMMISSIONER FOR PATENTS,

SIR:

Please enter the following amendments.

#### IN THE TITLE:

Please replace the title with the following new title: "THERMAL ANNEALING PROCESS FOR PRODUCING LOW DEFECT DENSITY SINGLE CRYSTAL SILICON."

#### IN THE SPECIFICATION:

Please replace the paragraph beginning at line 3, page 1 with the following rewritten paragraph:

# **CROSS-REFERENCE TO RELATED APPLICATION**

This patent application claims priority from U.S. Provisional Patent Application Serial No. 60/104,304 filed on October 14, 1998, and U.S. Serial No. 

#### IN THE CLAIMS:

Please cancel claims 1-18.